## Notice of References Cited Application/Control No. 10/762,082 Examiner Art Unit Page 1 of 1 U.S. PATENT DOCUMENTS Applicant(s)/Patent Under Reexamination TANAKA, YUKIO Art Unit Page 1 of 1

## Date **Document Number** Name Classification Country Code-Number-Kind Code MM-YYYY US-3,821,724 06-1974 Wamer 365/219 Α 12-2002 Saito et al. 345/98 US-6,501,456 В US-С D US-US-Ε US-F G US-Н US-US-US-US-Κ US-US-М

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